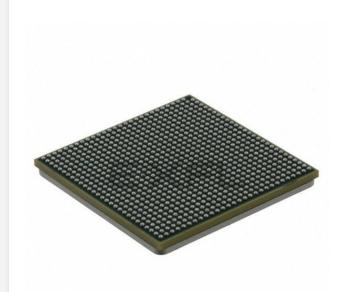
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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.333GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCBGA (29x29)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8548ehxauj

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Figure 4 shows the DDR SDRAM output timing diagram.+

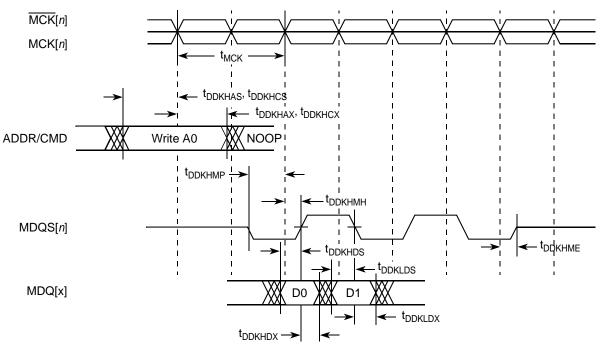


Figure 4. DDR SDRAM Output Timing Diagram

Figure 5 provides the AC test load for the DDR bus.

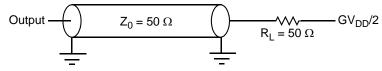


Figure 5. DDR AC Test Load

Enhanced Three-Speed Ethernet (eTSEC)

Figure 10 shows the GMII receive AC timing diagram.

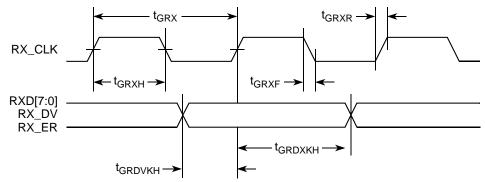


Figure 10. GMII Receive AC Timing Diagram

8.2.3 MII AC Timing Specifications

This section describes the MII transmit and receive AC timing specifications.

8.2.3.1 MII Transmit AC Timing Specifications

This table provides the MII transmit AC timing specifications.

Table 28. MII Transmit A	C Timing Specifications
--------------------------	-------------------------

Parameter/Condition	Symbol ¹	Min	Тур	Max	Unit
TX_CLK clock period 10 Mbps	t _{MTX} ²	_	400	—	ns
TX_CLK clock period 100 Mbps	t _{MTX}	_	40	—	ns
TX_CLK duty cycle	t _{MTXH} /t _{MTX}	35	_	65	%
TX_CLK to MII data TXD[3:0], TX_ER, TX_EN delay	t _{MTKHDX}	1	5	15	ns
TX_CLK data clock rise (20%–80%)	t _{MTXR} ²	1.0	_	4.0	ns
TX_CLK data clock fall (80%–20%)	t _{MTXF} ²	1.0	_	4.0	ns

Notes:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_(first two letters of functional block)(reference)(state)(signal)(state) for outputs. For example, t_{MTKHDX} symbolizes MII transmit timing (MT) for the time t_{MTX} clock reference (K) going high (H) until data outputs (D) are invalid (X). Note that, in general, the clock reference symbol representation is based on two to three letters representing the clock of a particular functional. For example, the subscript of t_{MTX} represents the MII(M) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
</sub>

2. Guaranteed by design.

Figure 11 shows the MII transmit AC timing diagram.

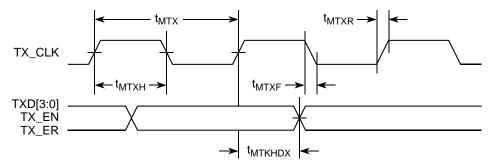


Figure 11. MII Transmit AC Timing Diagram

8.2.3.2 MII Receive AC Timing Specifications

This table provides the MII receive AC timing specifications.

Parameter/Condition	Symbol ¹	Min	Тур	Max	Unit
RX_CLK clock period 10 Mbps	t _{MRX} 2	_	400	_	ns
RX_CLK clock period 100 Mbps	t _{MRX}		40		ns
RX_CLK duty cycle	t _{MRXH} /t _{MRX}	35	_	65	%
RXD[3:0], RX_DV, RX_ER setup time to RX_CLK	t _{MRDVKH}	10.0	_	_	ns
RXD[3:0], RX_DV, RX_ER hold time to RX_CLK	t _{MRDXKH}	10.0	_	_	ns
RX_CLK clock rise (20%–80%)	t _{MRXR} ²	1.0	_	4.0	ns
RX_CLK clock fall time (80%–20%)	t _{MRXF} ²	1.0	_	4.0	ns

Notes:

1. The symbols used for timing specifications follow the pattern of t_{(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{MRDVKH} symbolizes MII receive timing (MR) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MRX} clock reference (K) going to the high (H) state or setup time. Also, t_{MRDXKL} symbolizes MII receive timing (GR) with respect to the time data input signals (D) went invalid (X) relative to the t_{MRX} clock reference (K) going to the low (L) state or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of t_{MRX} represents the MII (M) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).}

2. Guaranteed by design.

Figure 12 provides the AC test load for eTSEC.

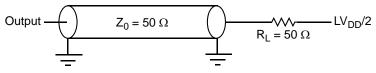


Figure 12. eTSEC AC Test Load

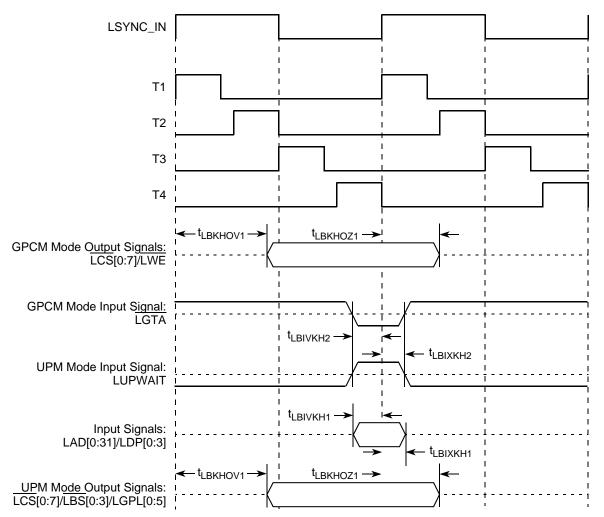


Figure 27. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 8 or 16 (PLL Enabled)

11 Programmable Interrupt Controller

In IRQ edge trigger mode, when an external interrupt signal is asserted (according to the programmed polarity), it must remain the assertion for at least 3 system clocks (SYSCLK periods).

12 JTAG

This section describes the DC and AC electrical specifications for the IEEE 1149.1 (JTAG) interface of the device.

12.1 JTAG DC Electrical Characteristics

This table provides the DC electrical characteristics for the JTAG interface.

Parameter	Symbol ¹	Min	Мах	Unit
High-level input voltage	V _{IH}	2	OV _{DD} + 0.3	V
Low-level input voltage	V _{IL}	-0.3	0.8	V
Input current $(V_{IN}^{1} = 0 \text{ V or } V_{IN} = V_{DD})$	I _{IN}	—	±5	μA
High-level output voltage ($OV_{DD} = min, I_{OH} = -2 mA$)	V _{OH}	2.4	_	V
Low-level output voltage ($OV_{DD} = min, I_{OL} = 2 mA$)	V _{OL}	—	0.4	V

 Table 43. JTAG DC Electrical Characteristics

Note:

1. Note that the symbol V_{IN} in this case, represents the OV_{IN}

12.2 JTAG AC Electrical Specifications

This table provides the JTAG AC timing specifications as defined in Figure 30 through Figure 32.

Parameter	Symbol ²	Min	Мах	Unit	Notes
JTAG external clock frequency of operation	f _{JTG}	0	33.3	MHz	
JTAG external clock cycle time	t _{JTG}	30	_	ns	_
JTAG external clock pulse width measured at 1.4 V	t _{JTKHKL}	15	_	ns	_
JTAG external clock rise and fall times	t _{JTGR} & t _{JTGF}	0	2	ns	6
TRST assert time	t _{TRST}	25	_	ns	3
Input setup times: Boundary-scan data TMS, TDI	t _{JTDVKH} t _{JTIVKH}	4 0		ns	4
Input hold times: Boundary-scan data TMS, TDI	^t jtdxkh ^t jtixkh	20 25		ns	4

Table 44. JTAG AC Timing Specifications (Independent of SYSCLK)¹

This table provides the PCI AC timing specifications at 66 MHz.

Table 52. PCI AC	Timing	Specifications	at 66	MHz
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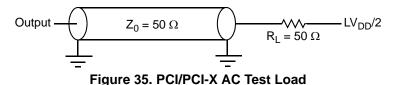
Parameter	Symbol ¹	Min	Мах	Unit	Notes
CLK to output valid	t _{PCKHOV}	_	6.0	ns	2, 3
Output hold from CLK	t _{PCKHOX}	2.0	—	ns	2, 10
CLK to output high impedance	t _{PCKHOZ}	_	14	ns	2, 4, 11
Input setup to CLK	t _{PCIVKH}	3.0	—	ns	2, 5, 10
Input hold from CLK	t _{PCIXKH}	0	—	ns	2, 5, 10
REQ64 to HRESET ⁹ setup time	t _{PCRVRH}	$10 imes t_{SYS}$	—	clocks	6, 7, 11
HRESET to REQ64 hold time	t _{PCRHRX}	0	50	ns	7, 11
HRESET high to first FRAME assertion	t _{PCRHFV}	10	—	clocks	8, 11

Notes:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t<sub>(first two letters of functional block)(reference)(state)(signal)(state) for outputs. For example, t_{PCIVKH} symbolizes PCI/PCI-X timing (PC) with respect to the time the input signals (I) reach the valid state (V) relative to the SYSCLK clock, t_{SYS}, reference (K) going to the high (H) state or setup time. Also, t_{PCRHFV} symbolizes PCI/PCI-X timing (PC) with respect to the time hard reset (R) went high (H) relative to the frame signal (F) going to the valid (V) state.
</sub></sub>

- 2. See the timing measurement conditions in the PCI 2.2 Local Bus Specifications.
- 3. All PCI signals are measured from $OV_{DD}/2$ of the rising edge of SYSCLK or PCI_CLK*n* to $0.4 \times OV_{DD}$ of the signal in question for 3.3-V PCI signaling levels.
- 4. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 5. Input timings are measured at the pin.
- 6. The timing parameter t_{SYS} indicates the minimum and maximum CLK cycle times for the various specified frequencies. The system clock period must be kept within the minimum and maximum defined ranges. For values see Section 20, "Clocking."
- 7. The setup and hold time is with respect to the rising edge of HRESET.
- 8. The timing parameter t_{PCRHFV} is a minimum of 10 clocks rather than the minimum of 5 clocks in the *PCI 2.2 Local Bus Specifications*.
- 9. The reset assertion timing requirement for $\overline{\text{HRESET}}$ is 100 μ s.
- 10. Guaranteed by characterization.
- 11.Guaranteed by design.

Figure 35 provides the AC test load for PCI and PCI-X.



- The SD_REF_CLK and SD_REF_CLK are internally AC-coupled differential inputs as shown in Figure 39. Each differential clock input (SD_REF_CLK or SD_REF_CLK) has a 50-Ω termination to SGND_SRDSn (xcorevss) followed by on-chip AC-coupling.
- The external reference clock driver must be able to drive this termination.
- The SerDes reference clock input can be either differential or single-ended. See the differential mode and single-ended mode description below for further detailed requirements.
- The maximum average current requirement that also determines the common mode voltage range:
 - When the SerDes reference clock differential inputs are DC coupled externally with the clock driver chip, the maximum average current allowed for each input pin is 8 mA. In this case, the exact common mode input voltage is not critical as long as it is within the range allowed by the maximum average current of 8 mA (see the following bullet for more detail), since the input is AC-coupled on-chip.
 - This current limitation sets the maximum common mode input voltage to be less than 0.4 V (0.4 V/50 = 8 mA) while the minimum common mode input level is 0.1 V above SGND_SRDS*n* (xcorevss). For example, a clock with a 50/50 duty cycle can be produced by a clock driver with output driven by its current source from 0 to 16 mA (0–0.8 V), such that each phase of the differential input has a single-ended swing from 0 V to 800 mV with the common mode voltage at 400 mV.
 - If the device driving the SD_REF_CLK and $\overline{\text{SD}_{\text{REF}_{\text{CLK}}}}$ inputs cannot drive 50 Ω to SGND_SRDS*n* (xcorevss) DC, or it exceeds the maximum input current limitations, then it must be AC-coupled off-chip.
- The input amplitude requirement:
 - This requirement is described in detail in the following sections.

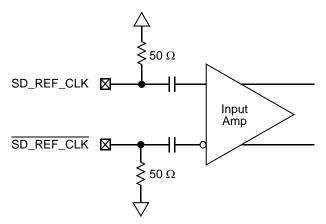


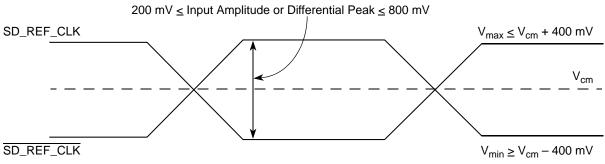
Figure 39. Receiver of SerDes Reference Clocks

16.2.2 DC Level Requirement for SerDes Reference Clocks

The DC level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs as described below:

• Differential mode

High-Speed Serial Interfaces (HSSI)





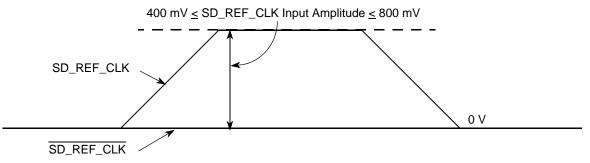


Figure 42. Single-Ended Reference Clock Input DC Requirements

16.2.3 Interfacing with Other Differential Signaling Levels

- With on-chip termination to SGND_SRDSn (xcorevss), the differential reference clocks inputs are HCSL (high-speed current steering logic) compatible DC-coupled.
- Many other low voltage differential type outputs like LVDS (low voltage differential signaling) can be used but may need to be AC-coupled due to the limited common mode input range allowed (100 to 400 mV) for DC-coupled connection.
- LVPECL outputs can produce signal with too large amplitude and may need to be DC-biased at clock driver output first, then followed with series attenuation resistor to reduce the amplitude, in addition to AC-coupling.

NOTE

Figure 43 through Figure 46 below are for conceptual reference only. Due to the fact that clock driver chip's internal structure, output impedance, and termination requirements are different between various clock driver chip manufacturers, it is very possible that the clock circuit reference designs provided by clock driver chip vendor are different from what is shown below. They might also vary from one vendor to the other. Therefore, Freescale Semiconductor can neither provide the optimal clock driver reference circuits, nor guarantee the correctness of the following clock driver connection reference circuits. The system designer is recommended to contact the selected clock driver chip vendor for the optimal reference circuits with the SerDes reference clock receiver requirement provided in this document.

PCI Express

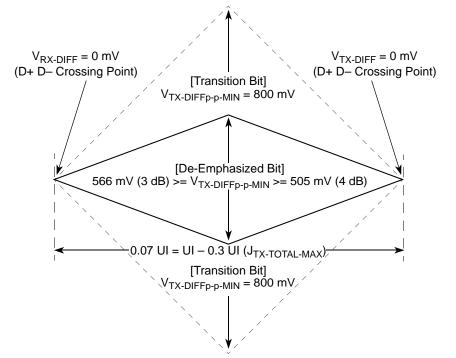


Figure 48. Minimum Transmitter Timing and Voltage Output Compliance Specifications

17.4.3 Differential Receiver (RX) Input Specifications

Table 57 defines the specifications for the differential input at all receivers (RXs). The parameters are specified at the component pins.

Symbol	Parameter	Min	Nom	Max	Unit	Comments
UI	Unit interval	399.88	400	400.12	ps	Each UI is 400 ps \pm 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1.
V _{RX-DIFFp-p}	Differential peak-to-peak input voltage	0.175	—	1.200	V	$V_{RX-DIFFp-p} = 2 \times V_{RX-D+} - V_{RX-D-} $. See Note 2.
T _{RX-EYE}	Minimum receiver eye width	0.4	_	_	UI	The maximum interconnect media and transmitter jitter that can be tolerated by the receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3.
T _{RX-EYE-MEDIAN-to-} MAX-JITTER	Maximum time between the jitter median and maximum deviation from the median	—		0.3	UI	Jitter is defined as the measurement variation of the crossing points ($V_{RX-DIFFp-p} = 0$ V) in relation to a recovered TX UI. A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI. See Notes 2, 3, and 7.

Table 57. Differential Receiver (RX) Input Specifications

PCI Express

The eye diagram must be valid for any 250 consecutive UIs.

A recovered TX UI is calculated over 3500 consecutive unit intervals of sample data. The eye diagram is created using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the TX UI.

NOTE

The reference impedance for return loss measurements is 50. to ground for both the D+ and D– line (that is, as measured by a vector network analyzer with 50- Ω probes—see Figure 50). Note that the series capacitors, CTX, are optional for the return loss measurement.

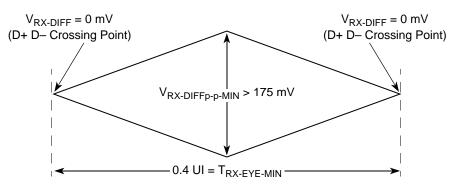


Figure 49. Minimum Receiver Eye Timing and Voltage Compliance Specification

17.5.1 Compliance Test and Measurement Load

The AC timing and voltage parameters must be verified at the measurement point, as specified within 0.2 inches of the package pins, into a test/measurement load shown in Figure 50.

NOTE

The allowance of the measurement point to be within 0.2 inches of the package pins is meant to acknowledge that package/board routing may benefit from D+ and D- not being exactly matched in length at the package pin boundary.

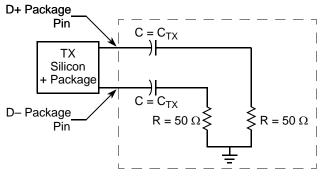


Figure 50. Compliance Test/Measurement Load

18.5 Explanatory Note on Transmitter and Receiver Specifications

AC electrical specifications are given for transmitter and receiver. Long- and short-run interfaces at three baud rates (a total of six cases) are described.

The parameters for the AC electrical specifications are guided by the XAUI electrical interface specified in Clause 47 of IEEE 802.3ae-2002.

XAUI has similar application goals to Serial RapidIO, as described in Section 8.1. The goal of this standard is that electrical designs for Serial RapidIO can reuse electrical designs for XAUI, suitably modified for applications at the baud intervals and reaches described herein.

18.6 Transmitter Specifications

LP-serial transmitter electrical and timing specifications are stated in the text and tables of this section.

The differential return loss, S11, of the transmitter in each case shall be better than:

- -10 dB for (baud frequency)/10 < Freq(f) < 625 MHz, and
- $-10 \text{ dB} + 10\log(f/625 \text{ MHz}) \text{ dB}$ for $625 \text{ MHz} \le \text{Freq}(f) \le \text{baud}$ frequency

The reference impedance for the differential return loss measurements is $100-\Omega$ resistive. Differential return loss includes contributions from on-chip circuitry, chip packaging, and any off-chip components related to the driver. The output impedance requirement applies to all valid output levels.

It is recommended that the 20%–80% rise/fall time of the transmitter, as measured at the transmitter output, in each case have a minimum value 60 ps.

It is recommended that the timing skew at the output of an LP-serial transmitter between the two signals that comprise a differential pair not exceed 25 ps at 1.25 GB, 20 ps at 2.50 GB, and 15 ps at 3.125 GB.

Characteristic	Characteristic Symbol Range Unit		Notes		
Characteristic	Symbol	Min	Max	Unit	Notes
Output voltage	Vo	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	V _{DIFFPP}	500	1000	mV p-p	_
Deterministic jitter	J _D	_	0.17	UI p-p	_
Total jitter	J _T	_	0.35	UI p-p	_
Multiple output skew	S _{MO}	_	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit Interval	UI	800	800	ps	±100 ppm

Table 59. Short Run Transmitter	AC Timing Spe	cifications—1.25 GBaud
	Ao mining ope	

18.8 Receiver Eye Diagrams

For each baud rate at which an LP-serial receiver is specified to operate, the receiver shall meet the corresponding bit error rate specification (Table 66, Table 67, and Table 68) when the eye pattern of the receiver test signal (exclusive of sinusoidal jitter) falls entirely within the unshaded portion of the receiver input compliance mask shown in Figure 54 with the parameters specified in Table 69. The eye pattern of the receiver test signal is measured at the input pins of the receiving device with the device replaced with a $100-\Omega \pm 5\%$ differential resistive load.

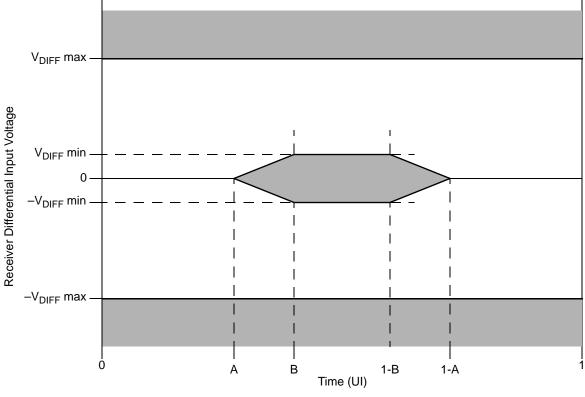


Figure 54. Receiver Input Compliance Mask

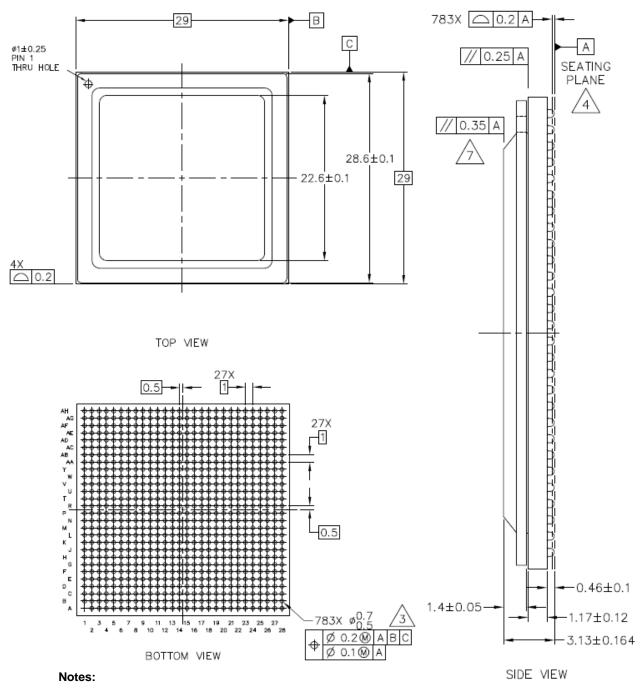
Table 69. Receiver Input Compliance Mask Parameters Exclusive of Sinusoidal Jitter

Receiver Type	V _{DIFF} min (mV)	V _{DIFF} max (mV)	A (UI)	B (UI)
1.25 GBaud	100	800	0.275	0.400
2.5 GBaud	100	800	0.275	0.400
3.125 GBaud	100	800	0.275	0.400

18.9 Measurement and Test Requirements

Since the LP-serial electrical specification are guided by the XAUI electrical interface specified in Clause 47 of IEEE Std. 802.3ae-2002, the measurement and test requirements defined here are similarly guided by Clause 47. Additionally, the CJPAT test pattern defined in Annex 48A of IEEE Std.

Package Description



- 1. All dimensions are in millimeters.
- 2. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 3. Maximum solder ball diameter measured parallel to datum A.
- 4. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- 5. Capacitors may not be present on all devices.
- 6. Caution must be taken not to short capacitors or exposed metal capacitor pads on package top.
- 7. Parallelism measurement shall exclude any effect of mark on top surface of package.
- 8. All dimensions are symmetric across the package center lines unless dimensioned otherwise.

Figure 56. Mechanical Dimensions and Bottom Surface Nomenclature of the FC-PBGA with Stamped Lid

Package Description

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	Local Bus Controller Interface			
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	BV _{DD}	_
LDP[0:3]	K21, C28, B26, B22	I/O	BV _{DD}	—
LA[27]	H21	0	BV _{DD}	5, 9
LA[28:31]	H20, A27, D26, A28	0	BV _{DD}	5, 7, 9
LCS[0:4]	J25, C20, J24, G26, A26	0	BV _{DD}	—
LCS5/DMA_DREQ2	D23	I/O	BV _{DD}	1
LCS6/DMA_DACK2	G20	0	BV _{DD}	1
LCS7/DMA_DDONE2	E21	0	BV _{DD}	1
LWE0/LBS0/LSDDQM[0]	G25	0	BV _{DD}	5, 9
LWE1/LBS1/LSDDQM[1]	C23	0	BV _{DD}	5, 9
LWE2/LBS2/LSDDQM[2]	J21	0	BV _{DD}	5, 9
LWE3/LBS3/LSDDQM[3]	A24	0	BV _{DD}	5, 9
LALE	H24	0	BV _{DD}	5, 8, 9
LBCTL	G27	0	BV _{DD}	5, 8, 9
LGPL0/LSDA10	F23	0	BV _{DD}	5, 9
LGPL1/LSDWE	G22	0	BV _{DD}	5, 9
LGPL2/LOE/LSDRAS	B27	0	BV _{DD}	5, 8, 9
LGPL3/LSDCAS	F24	0	BV _{DD}	5, 9
LGPL4/LGTA/LUPWAIT/LPBSE	H23	I/O	BV _{DD}	—
LGPL5	E26	0	BV _{DD}	5, 9
LCKE	E24	0	BV _{DD}	—
LCLK[0:2]	E23, D24, H22	0	BV _{DD}	—
LSYNC_IN	F27	I	BV _{DD}	—
LSYNC_OUT	C_OUT F28		BV _{DD}	—
	DMA			
DMA_DACK[0:1]	AD3, AE1	0	OV _{DD}	5, 9, 107
DMA_DREQ[0:1]	AD4, AE2	I	OV _{DD}	_
DMA_DDONE[0:1]	AD2, AD1	0	OV _{DD}	_
	Programmable Interrupt Controller			
UDE	AH16	I	OV _{DD}	_
MCP	AG19	l	OV _{DD}	_

Package Description

Signal	Package Pin Number	Pin Type	Power Supply	Notes
BV _{DD}	C21, C24, C27, E20, E25, G19, G23, H26, J20	Power for local bus (1.8 V, 2.5 V, 3.3 V)	BV _{DD}	_
V _{DD}	M19, N12, N14, N16, N18, P11, P13, P15, P17, P19, R12, R14, R16, R18, T11, T13, T15, T17, T19, U12, U14, U16, U18, V17, V19	Power for core (1.1 V)	V _{DD}	_
SV _{DD}	L25, L27, M24, N28, P24, P26, R24, R27, T25, V24, V26, W24, W27, Y25, AA28, AC27	Core power for SerDes transceivers (1.1 V)	SV _{DD}	
XV _{DD}	L20, L22, N23, P21, R22, T20, U23, V21, W22, Y20	Pad Power for SerDes transceivers (1.1 V)	XV _{DD}	
AVDD_LBIU	J28	Power for local bus PLL (1.1 V)	_	26
AVDD_PCI1	AH21	Power for PCI1 PLL (1.1 V)	_	26
AVDD_PCI2	AH22	Power for PCI2 PLL (1.1 V)	_	26
AVDD_CORE	AH15	Power for e500 PLL (1.1 V)	_	26
AVDD_PLAT	AH19	Powerfor CCB PLL (1.1 V)		26
AVDD_SRDS	U25	Power for SRDSPLL (1.1 V)	_	26
SENSEVDD	M14	0	V _{DD}	13
SENSEVSS	M16	—		13
	Analog Signals			
MVREF	A18	I Reference voltage signal for DDR	MVREF	
SD_IMP_CAL_RX	L28	I	200 Ω to GND	_
SD_IMP_CAL_TX	AB26	I	100 Ω to GND	

Table 72. MPC8547E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
SD_IMP_CAL_RX	L28	I	200 Ω to GND	—
SD_IMP_CAL_TX	AB26	I	100 Ω to GND	—
SD_PLL_TPA	U26	0	_	24

Table 73. MPC8545E Pinout Listing (continued)

Note: All note references in this table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Table 74 provides the pin-out listing for the MPC8543E 783 FC-PBGA package.

NOTE

All note references in the following table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Table 74. MPC8543E Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	PCI1 (One 32-Bit)			
Reserved	AB14, AC15, AA15, Y16, W16, AB16, AC16, AA16, AE17, AA18, W18, AC17, AD16, AE16, Y17, AC18,		_	110
GPOUT[8:15]	AB18, AA19, AB19, AB21, AA20, AC20, AB20, AB22	0	OV _{DD}	—
GPIN[8:15]	AC22, AD21, AB23, AF23, AD23, AE23, AC23, AC24	I	OV _{DD}	111
PCI1_AD[31:0]	AH6, AE7, AF7, AG7, AH7, AF8, AH8, AE9, AH9, AC10, AB10, AD10, AG10, AA10, AH10, AA11, AB12, AE12, AG12, AH12, AB13, AA12, AC13, AE13, Y14, W13, AG13, V14, AH13, AC14, Y15, AB15	I/O	OV _{DD}	17
Reserved	AF15, AD14, AE15, AD15	_	-	110
PCI1_C_BE[3:0]	AF9, AD11, Y12, Y13	I/O	OV _{DD}	17
Reserved	W15			110
PCI1_GNT[4:1]	AG6, AE6, AF5, AH5	0	OV _{DD}	5, 9, 35
PCI1_GNT0	AG5	I/O	OV _{DD}	—
PCI1_IRDY	AF11	I/O	OV _{DD}	2
PCI1_PAR	AD12	I/O	OV _{DD}	—
PCI1_PERR	AC12	I/O	OV _{DD}	2
PCI1_SERR	V13	I/O	OV _{DD}	2, 4
PCI1_STOP	W12	I/O	OV _{DD}	2

Signal	Package Pin Number	Pin Type	Power Supply	Notes
GPOUT[0:5]	N9, N10, P8, N7, R9, N5	0	LV _{DD}	_
cfg_dram_type0/GPOUT6	R8	0	LV _{DD}	5, 9
GPOUT7	N6	0	LV _{DD}	-
Reserved	P1		_	104
Reserved	R6		_	104
Reserved	P6		_	15
Reserved	N4	_	_	105
FIFO1_RXC2	P5	I	LV _{DD}	104
Reserved	R1	—	_	104
Reserved	P10	_	_	105
FIFO1_TXC2	P7	0	LV _{DD}	15
cfg_dram_type1	R10	0	LV _{DD}	5, 9
Three	ee-Speed Ethernet Controller (Gigabit	Ethernet 3)		
TSEC3_TXD[3:0]	V8, W10, Y10, W7	0	TV _{DD}	5, 9, 2
TSEC3_RXD[3:0]	Y1, W3, W5, W4	I	TV _{DD}	_
TSEC3_GTX_CLK	W8	0	TV _{DD}	_
TSEC3_RX_CLK	W2	I	TV _{DD}	—
TSEC3_RX_DV	W1	I	TV _{DD}	-
TSEC3_RX_ER	Y2	I	TV _{DD}	_
TSEC3_TX_CLK	V10	I	TV _{DD}	_
TSEC3_TX_EN	V9	0	TV _{DD}	30
TSEC3_TXD[7:4]	AB8, Y7, AA7, Y8	0	TV _{DD}	5, 9, 2
TSEC3_RXD[7:4]	AA1, Y3, AA2, AA4	I	TV _{DD}	_
Reserved	AA5	_	_	15
TSEC3_COL	Y5	I	TV _{DD}	- 1
TSEC3_CRS	AA3	I/O	TV _{DD}	31
TSEC3_TX_ER	AB6	0	TV _{DD}	-
	DUART			
UART_CTS[0:1]	AB3, AC5	I	OV _{DD}	-
UART_RTS[0:1]	AC6, AD7	0	OV _{DD}	1 -
UART_SIN[0:1]	AB5, AC7		OV _{DD}	<u> </u>
UART_SOUT[0:1]	AB7, AD8	0	OV _{DD}	<u> </u>
	I ² C interface	I		_1
IIC1_SCL	AG22	I/O	OV _{DD}	4, 27
		1		

Table 74. MPC8543E Pinout Listing (continued)

System Design Information

22.10 Guidelines for High-Speed Interface Termination

This section provides the guidelines for high-speed interface termination when the SerDes interface is entirely unused and when it is partly unused.

22.10.1 SerDes Interface Entirely Unused

If the high-speed SerDes interface is not used at all, the unused pin must be terminated as described in this section.

The following pins must be left unconnected (float):

- SD_TX[7:0]
- <u>SD_TX</u>[7:0]
- Reserved pins T22, T23, M20, M21

The following pins must be connected to GND:

- SD_RX[7:0]
- <u>SD_RX</u>[7:0]
- SD_REF_CLK
- SD_REF_CLK

NOTE

It is recommended to power down the unused lane through SRDSCR1[0:7] register (offset = $0xE_0F08$) (This prevents the oscillations and holds the receiver output in a fixed state.) that maps to SERDES lane 0 to lane 7 accordingly.

Pins V28 and M26 must be tied to XV_{DD} . Pins V27 and M25 must be tied to GND through a 300- Ω resistor.

In Rev 2.0 silicon, POR configuration pin cfg_srds_en on TSEC4_TXD[2]/TSEC3_TXD[6] can be used to power down SerDes block.

22.10.2 SerDes Interface Partly Unused

If only part of the high-speed SerDes interface pins are used, the remaining high-speed serial I/O pins must be terminated as described in this section.

The following pins must be left unconnected (float) if not used:

- SD_TX[7:0]
- <u>SD_TX</u>[7:0]
- Reserved pins: T22, T23, M20, M21

The following pins must be connected to GND if not used:

- SD_RX[7:0]
- $\overline{\text{SD}_{RX}}[7:0]$
- SD_REF_CLK

23.2 Part Marking

Parts are marked as the example shown in Figure 64.



Notes:

TWLYYWW is final test traceability code. MMMMM is 5 digit mask number. CCCCC is the country of assembly. This space is left blank if parts are assembled in the United States. YWWLAZ is assembly traceability code.

Figure 64. Part Marking for CBGA and PBGA Device

Rev. Number	Date	Substantive Change(s)
4	04/2009	 In Table 1, "Absolute Maximum Ratings ¹," and in Table 2, "Recommended Operating Conditions," moved text, "MII management voltage" from LV_{DD}/TV_{DD} to OV_{DD}, added "Ethernet management" to OVDD row of input voltage section. In Table 5, "SYSCLK AC Timing Specifications," added notes 7 and 8 to SYSCLK frequency and cycle time. In Table 36, "MII Management DC Electrical Characteristics," changed all instances of LV_{DD}/OV_{DD} to OV_{DD}. Modified Section 16, "High-Speed Serial Interfaces (HSSI)," to reflect that there is only one SerDes. Modified DDR clk rate min from 133 to 166 MHz. Modified note in Table 75, "Processor Core Clocking Specifications (MPC8548E and MPC8547E), "." In Table 56, "Differential Transmitter (TX) Output Specifications," modified equations in Comments column, and changed all instances of "LO" to "L0." Also added note 8. In Table 57, "Differential Receiver (RX) Input Specifications," modified equations in Comments column, and in note 3, changed "TRX-EYE-MEDIAN-to-MAX-JITTER," to "T_{RX-EYE-MEDIAN-to-MAX-JITTER}." Modified Table 83, "Frequency Options of SYSCLK with Respect to Memory Bus Speeds." Added a note on Section 4.1, "System Clock Timing," to limit the SYSCLK to 100 MHz if the core frequency is less than 1200 MHz In Table 71, "MPC8543E Pinout ListingTable 72, "MPC8547E Pinout ListingTable 73, "MPC8545E Pinout ListingTable 74, "MPC8543E Pinout Listing," added note 5 to LA[28:31]. Added note to Table 83, "Frequency Options of SYSCLK with Respect to Memory Bus Speeds."
3	01/2009	 [Section 4.6, "Platform Frequency Requirements for PCI-Express and Serial RapidIO." Changed minimum frequency equation to be 527 MHz for PCI x8. In Table 5, added note 7. Section 4.5, "Platform to FIFO Restrictions." Changed platform clock frequency to 4.2. Section 8.1, "Enhanced Three-Speed Ethernet Controller (eTSEC) (10/100/1Gb Mbps)—GMII/MII/TBI/RGMII/RTBI/RMII Electrical Characteristics." Added MII after GMII and add 'or 2.5 V' after 3.3 V. In Table 23, modified table title to include GMII, MII, RMII, and TBI. In Table 24 and Table 25, changed clock period minimum to 5.3. In Table 26, Table 27, Table 28, Table 29, and Table 30, removed subtitle from table title. In Table 30 and Figure 15, changed all instances of PMA to TSEC<i>n</i>. In Table 34, Table 35, Figure 18, and Figure 20, changed all instances of REF_CLK to TSEC<i>n</i>_TX_CLK. In Table 36, changed all instances of OV_{DD} to LV_{DD}/TV_{DD}. In Table 36, changed all instances of OV_{DD} to LV_{DD}/TV_{DD}. In Table 37, "MII Management AC Timing Specifications," changed MDC minimum clock pulse width high from 32 to 48 ns. Added new section, Section 16, "High-Speed Serial Interfaces (HSSI)." Section 16.1, "DC Requirements for PCI Express SD_REF_CLK and SD_REF_CLK." Added new paragraph. Section 17.1, "DC Requirements for Serial RapidIO SD_REF_CLK and SD_REF_CLK." Added new paragraph. Added information to Figure 63, both in figure and in note. Section 22.3, "Decoupling Recommendations." Modified the recommendation. Table 87, "Part Numbering Nomenclature." In Silicon Version column added Ver. 2.1.2.

Table 88. Document Revision History (continued)